

# TC74HC175AP, TC74HC175AF, TC74HC175AFN

## Quad D-Type Flip Flop with Clear

The TC74HC175A is a high speed CMOS D-TYPE FLIP FLOP fabricated with silicon gate C2MOS technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

Information signals applied to D inputs are transferred to the Q and  $\bar{Q}$  outputs on the positive going edge of the clock pulse.

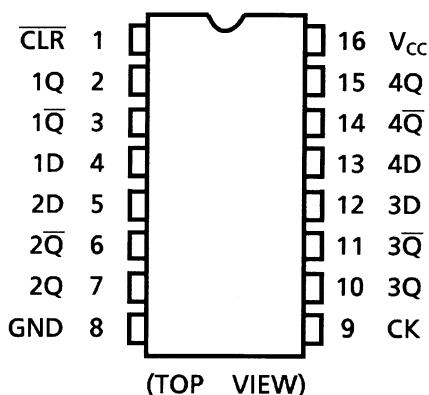
When the  $\overline{\text{CLR}}$  input is held low, the Q outputs are at the low logic level and the  $\bar{Q}$  outputs are at the high logic level independent of the other inputs.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

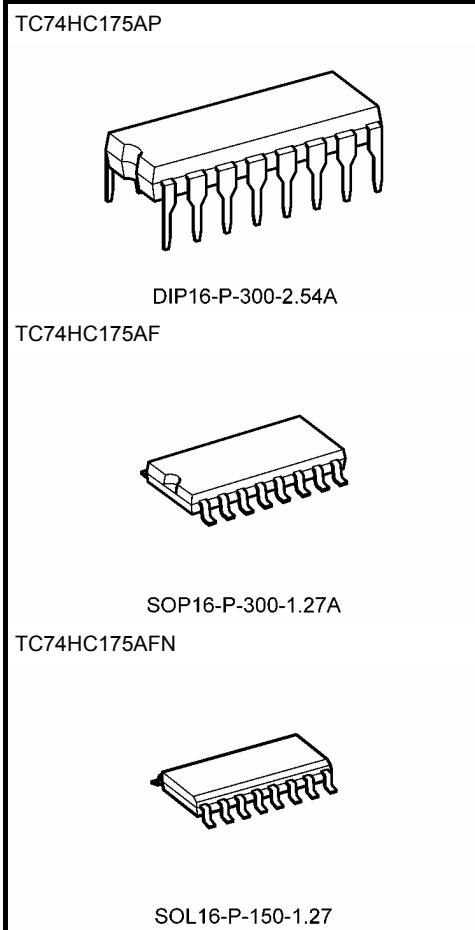
## Features

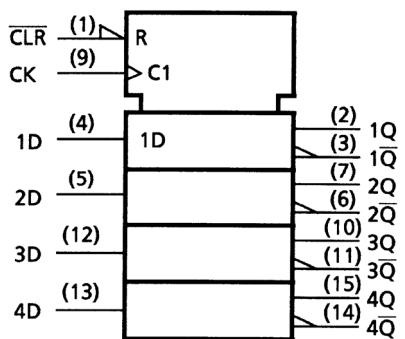
- High speed:  $f_{\max} = 63$  MHz (typ.) at  $V_{CC} = 5$  V
- Low power dissipation:  $I_{CC} = 4 \mu\text{A}$  (max) at  $T_a = 25^\circ\text{C}$
- High noise immunity:  $V_{NIH} = V_{NIL} = 28\%$   $V_{CC}$  (min)
- Symmetrical output impedance:  $|I_{OH}| = I_{OL} = 4$  mA (min)
- Balanced propagation delays:  $t_{PLH} \approx t_{PHL}$
- Wide operating voltage range:  $V_{CC}$  (opr) = 2 to 6 V
- Pin and function compatible with 74LS175

## Pin Assignment



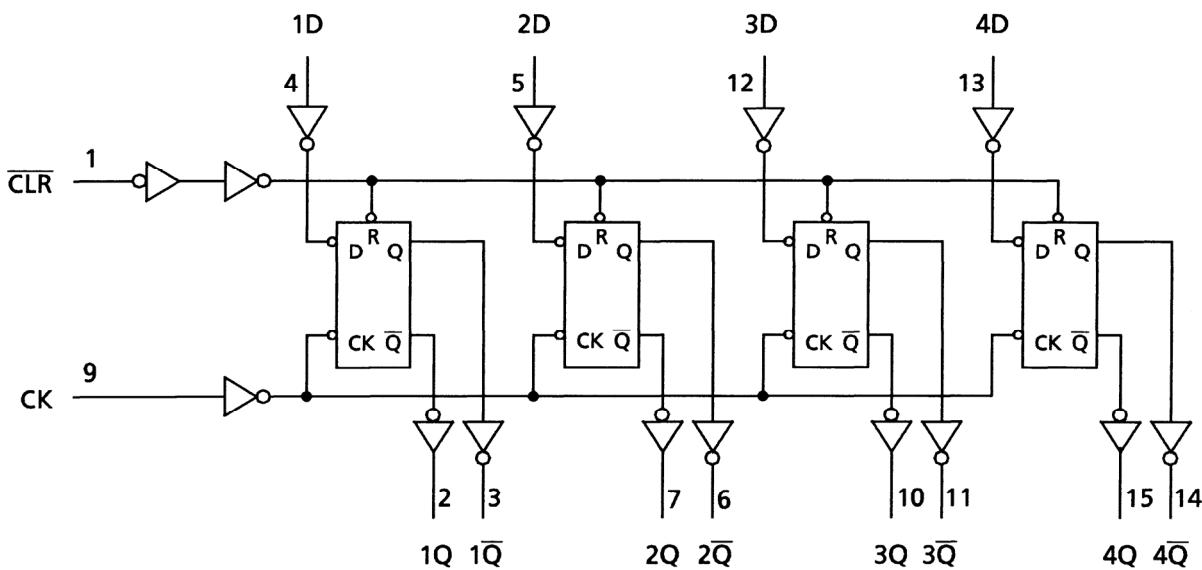
Note: xxxFN (JEDEC SOP) is not available in Japan.



**IEC Logic Symbol****Truth Table**

Inputs			Outputs		Function
CLR	D	CK	Q	$\bar{Q}$	
L	X	X	L	H	Clear
H	L	↑	L	H	—
H	H	↑	H	L	—
H	X	↓	$Q_n$	$\bar{Q}_n$	No Change

X: Don't care

**System Diagram**

**Absolute Maximum Ratings (Note 1)**

Characteristics	Symbol	Rating	Unit
Supply voltage range	V <sub>CC</sub>	-0.5 to 7	V
DC input voltage	V <sub>IN</sub>	-0.5 to V <sub>CC</sub> + 0.5	V
DC output voltage	V <sub>OUT</sub>	-0.5 to V <sub>CC</sub> + 0.5	V
Input diode current	I <sub>IK</sub>	±20	mA
Output diode current	I <sub>OK</sub>	±20	mA
DC output current	I <sub>OUT</sub>	±25	mA
DC V <sub>CC</sub> /ground current	I <sub>CC</sub>	±50	mA
Power dissipation	P <sub>D</sub>	500 (DIP) (Note 2)/180 (SOP)	mW
Storage temperature	T <sub>STG</sub>	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Note 2: 500 mW in the range of Ta = -40 to 65°C. From Ta = 65 to 85°C a derating factor of -10 mW/°C shall be applied until 300 mW.

**Operating Ranges (Note)**

Characteristics	Symbol	Rating	Unit
Supply voltage	V <sub>CC</sub>	2 to 6	V
Input voltage	V <sub>IN</sub>	0 to V <sub>CC</sub>	V
Output voltage	V <sub>OUT</sub>	0 to V <sub>CC</sub>	V
Operating temperature	T <sub>opr</sub>	-40 to 85	°C
Input rise and fall time	t <sub>r</sub> , t <sub>f</sub>	0 to 1000 (V <sub>CC</sub> = 2.0 V) 0 to 500 (V <sub>CC</sub> = 4.5 V) 0 to 400 (V <sub>CC</sub> = 6.0 V)	ns

Note: The operating ranges must be maintained to ensure the normal operation of the device.  
Unused inputs must be tied to either V<sub>CC</sub> or GND.

**Electrical Characteristics****DC Characteristics**

Characteristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Ta = 25°C			Ta = -40 to 85°C		Unit	
					Min	Typ.	Max	Min	Max		
High-level input voltage	V <sub>IH</sub>	—		2.0	1.50	—	—	1.50	—	V	
				4.5	3.15	—	—	3.15	—		
				6.0	4.20	—	—	4.20	—		
Low-level input voltage	V <sub>IL</sub>	—		2.0	—	—	0.50	—	0.50	V	
				4.5	—	—	1.35	—	1.35		
				6.0	—	—	1.80	—	1.80		
High-level output voltage	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -20 µA	2.0	1.9	2.0	—	1.9	—	V	
				4.5	4.4	4.5	—	4.4	—		
				6.0	5.9	6.0	—	5.9	—		
			I <sub>OH</sub> = -4 mA	4.5	4.18	4.31	—	4.13	—		
				6.0	5.68	5.80	—	5.63	—		
			I <sub>OL</sub> = 20 µA	2.0	—	0.0	0.1	—	0.1	V	
Low-level output voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>		4.5	—	0.0	0.1	—	0.1		
				6.0	—	0.0	0.1	—	0.1		
		I <sub>OL</sub> = 4 mA	4.5	—	0.17	0.26	—	0.33			
			6.0	—	0.18	0.26	—	0.33			
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		6.0	—	—	±0.1	—	±1.0	µA	
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		6.0	—	—	4.0	—	40.0	µA	

**Timing Requirements (input:  $t_r = t_f = 6 \text{ ns}$ )**

Characteristics	Symbol	Test Condition	$T_a = 25^\circ\text{C}$		$T_a = -40 \text{ to } 85^\circ\text{C}$		Unit
			$V_{CC} (\text{V})$	Typ.	Limit	Limit	
Minimum pulse width (CK)	$t_W (\text{L})$ $t_W (\text{H})$	—	2.0	—	75	95	ns
			4.5	—	15	19	
			6.0	—	13	16	
Minimum pulse width ( $\overline{\text{CLR}}$ )	$t_W (\text{L})$	—	2.0	—	75	95	ns
			4.5	—	15	19	
			6.0	—	13	16	
Minimum set-up time	$t_s$	—	2.0	—	75	95	ns
			4.5	—	15	19	
			6.0	—	13	16	
Minimum hold time	$t_h$	—	2.0	—	0	0	ns
			4.5	—	0	0	
			6.0	—	0	0	
Minimum removal time	$t_{rem}$	—	2.0	—	75	95	ns
			4.5	—	15	19	
			6.0	—	13	16	
Clock frequency	$f$	—	2.0	—	6	5	MHz
			4.5	—	31	25	
			6.0	—	36	29	

**AC Characteristics ( $C_L = 15 \text{ pF}$ ,  $V_{CC} = 5 \text{ V}$ ,  $T_a = 25^\circ\text{C}$ , input:  $t_r = t_f = 6 \text{ ns}$ )**

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Output transition time	$t_{TLH}$ $t_{THL}$	—	—	4	8	ns
Propagation delay time (CK-Q, $\overline{Q}$ )	$t_{pLH}$ $t_{pHL}$	—	—	16	24	ns
Propagation delay time ( $\overline{\text{CLR}}$ -Q, $\overline{Q}$ )	$t_{pLH}$ $t_{pHL}$	—	—	13	21	ns
Maximum clock frequency	$f_{max}$	—	36	63	—	MHz

AC Characteristics ( $C_L = 50 \text{ pF}$ , input:  $t_r = t_f = 6 \text{ ns}$ )

Characteristics	Symbol	Test Condition	Ta = 25°C			Ta = -40 to 85°C		Unit
			V <sub>CC</sub> (V)	Min	Typ.	Max	Min	
Output transition time	$t_{TLH}$	—	2.0	—	30	75	—	95
	$t_{THL}$		4.5	—	8	15	—	19
			6.0	—	7	13	—	16
Propagation delay time (CK-Q, $\bar{Q}$ )	$t_{pLH}$	—	2.0	—	70	140	—	175
	$t_{pHL}$		4.5	—	19	28	—	35
			6.0	—	16	24	—	30
Propagation delay time ( $\bar{CLR}$ -Q, $\bar{Q}$ )	$t_{pLH}$	—	2.0	—	50	125	—	160
	$t_{pHL}$		4.5	—	16	25	—	32
			6.0	—	12	22	—	27
Maximum clock frequency	$f_{max}$	—	2.0	6	14	—	5	—
			4.5	31	53	—	25	—
			6.0	36	63	—	29	—
Input capacitance	C <sub>IN</sub>	—	—	—	5	10	—	10
Power dissipation capacitance	C <sub>PD</sub> (Note)	—	—	—	53	—	—	pF

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC} (\text{opr}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/4 \text{ (per F/F)}$$

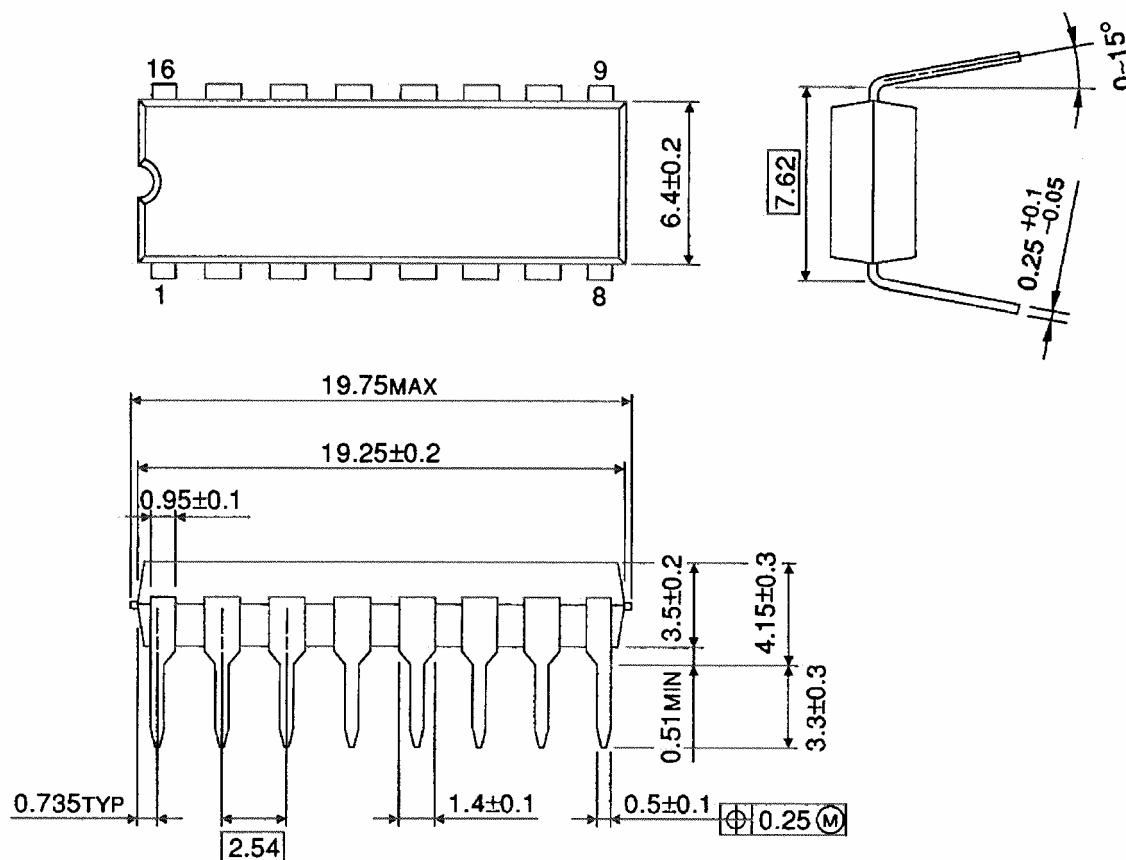
And the total C<sub>PD</sub> when n pcs. of Flip Flop operate can be gained by the following equation:

$$C_{PD} (\text{total}) = 32 + 21 \cdot n$$

**Package Dimensions**

DIP16-P-300-2.54A

Unit : mm

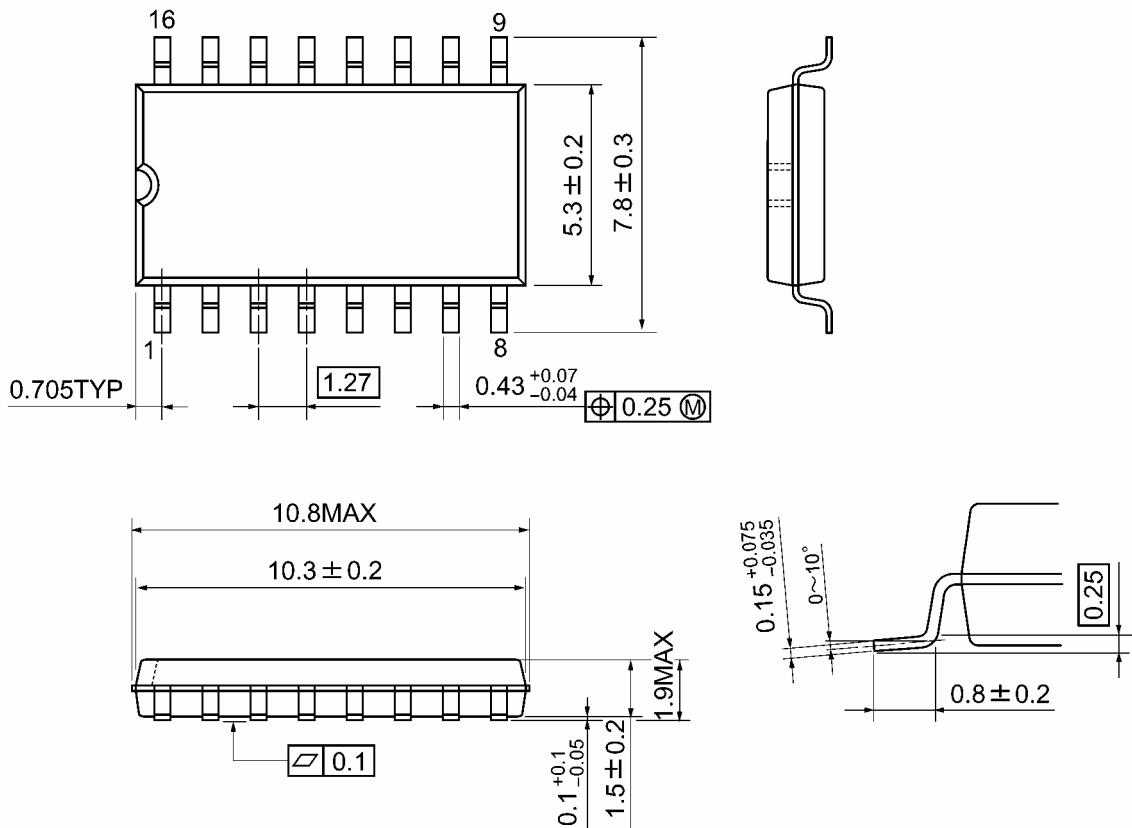


Weight: 1.00 g (typ.)

**Package Dimensions**

SOP16-P-300-1.27A

Unit: mm

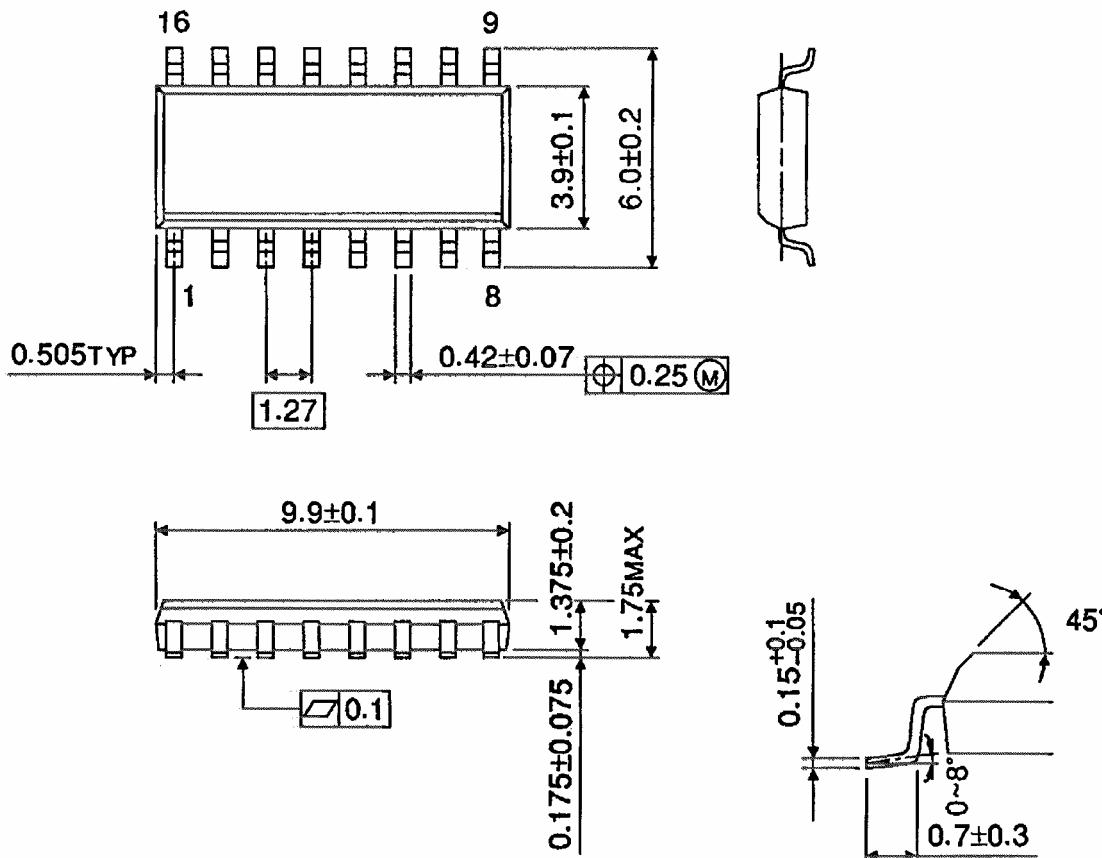


Weight: 0.18 g (typ.)

**Package Dimensions (Note)**

SOL16-P-150-1.27

Unit : mm



Note: This package is not available in Japan.

Weight: 0.13 g (typ.)

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20070701-EN GENERAL

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